

Search Notes

Application/Control No.

10/086,602

Examiner

Steven HD Nguyen

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	352, 466	3/31/2006	ST

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR